

Notic of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination FUJII, TAKEHIRO	
	09/674,522	Examiner	Art Unit
	Joseph Nguyen	2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
A	US-5814837	09-1998	Okazaki	257	91
B	US-Re, 36614	03-2000	Lumbard et al	313	500
C	US-6093940	07-2000	Ishinaga et al	257	99
D	US-				
E	US-				
F	US-				
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US- *				

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.